

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/700,310	ROBINSON, IAN	
Examiner		Art Unit		Page 1 of 1
SIU M. LEE		2611		

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,081,515	06-2000	Toivola, Peter	370/339
*	B	US-6,611,565	08-2003	Bada et al.	375/295
*	C	US-6,115,368	09-2000	Schilling, Donald L.	370/335
*	D	US-6,944,139	09-2005	Campanella, S. Joseph	370/315
*	E	US-2002/0080887	06-2002	Jeong et al.	375/295
*	F	US-6,291,924	09-2001	Lau et al.	310/313R
*	G	US-6,664,921	12-2003	Pratt, Anthony R.	342/357.06
*	H	US-5,805,983	09-1998	Naidu et al.	455/67.16
*	I	US-2002/0196876	12-2002	Takada, Masatoshi	375/346
*	J	US-2006/0072520	04-2006	Chitrapu et al.	370/337
*	K	US-6,473,416	10-2002	Lee, Kyung Kuk	370/342
*	L	US-2005/0218984	10-2005	Yin, Guangming	330/257
*	M	US-6,128,470	10-2000	Naidu et al.	455/16

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.